

Notice of References Cited	Application/Control No. 10/605,944	Applicant(s)/Patent Under Reexamination BOUDON ET AL.	
	Examiner Eric C. Wai	Art Unit 2195	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,596,540	01-1997	Diem et al.	365/221
	B	US-			
	C	US-			
	D	US-			
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	F	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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